

13/13/01

503 296

250	492.2
Class	Subclass

ISSUE CLASSIFICATION

Best Available Copy

PATENT NUMBER

U.S. UTILITY Patent Application

1KW
SCANNED 700 O.I.P.E. Q.A. 108

PATENT DATE

APPLICATION NO. 09/733980	CONT/PRIOR F	CLASS 250	SUBCLASS 358	ART UNIT 2881	EXAMINER Wells
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ANTS Masato Muraki
Yoshikiyo Yui

Charged-particle beam exposure apparatus, charged-particle beam exposure method, control data determination method, and device manufacturing method using this method

PTO-2040
12/89

ISSUING CLASSIFICATION

ORIGINAL				CROSS REFERENCE(S)									
CLASS		SUBCLASS		CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)								
250		492.22		250	492.2	492.3	398						
INTERNATIONAL CLASSIFICATION				480	296								
503	F	9/00											

☐ **TERMINAL
DISCLAIMER**

☐ The term of this patent subsequent to _____ has been disclaimed.

☐ The term of this patent shall not extend beyond the expiration of U.S. Patent No. _____

☐ The terminal _____ more
this patent have been disc

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Form PTO-438A
(Rev. 6/99)

DRAWINGS

Sheets Drwg.	Figs. Drwg.	Print Fig.
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(Assistant Examiner) _____ (Date) _____

(Primary Examiner) _____ (Date) _____

(Local Instrumental Examiner) _____ (Date) _____

CLAIMS ALLOWED

Total Claims	Print Claim for O.G.
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NOTICE OF ALLOWANCE MAILED

ISSUE FEE

Amount Due	Date Paid
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ISSUE BATCH NUMBER

FILED WITH: ☐ DISK (CRF) ☐ FICHE ☐ CD-ROM
(Attached in pocket on right inside flap)

Formal Drawings: sheet 501

(FACE)

1200